

attoMFM Ixs

low temperature atomic / magnetic force microscope, interferometric sensor

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Microscope Setup	
MFM sensor unit	ultra-stable MFM head, interferometric deflection detection
cantilever sensor adjustment	fixed, stable adjustment of the cantilever sensor
titanium housing diameter	25 mm (others on request)
Operation Modes	
feedback	PI feedback loop with additional PLL
imaging modes	contact mode, non-contact mode AFM, EFM, SGM, ct-AFM (conducting tip AFM)
Sample Positioning	
positioners and scanners	coarse positioners ANPxyz51 with piezo scanner ANSxyz50
coarse range	3 x 3 x 2.5 mm ³
step size	0.025 .. 2 µm @ 300 K, 10 .. 500 nm @ 4 K
fine scan range	30 x 30 x 4.3 µm ³ @ 300 K, 12 x 12 x 2 µm ³ @ 4 K
Operating Conditions	
temperature range	mK .. 400 K (dependent on cryostat)
magnetic field range	0 .. 16 T (depending on cryostat)
operating pressure range	1E-6 mbar .. 1 bar (designed for exchange gas atmosphere)
Cooling Specifications	
bore size	designed for a 1" or 25.4 mm cryostat/dewar bore
cryostat	LTSYS-He4, LTSYS-He3, LTSYS-HeDIL on request
Probes	
probe design	compatible with standard commercial cantilevers
functional probes	compatible with coated and non-coated probes, magnetic probes, ...
Resolution	
lateral magnetic resolution	< 20 nm
force gradient detection limit	< 0.2 µN/m (expected)
(4 K, bandwidth 1 kHz, 2 N/m)	< 0.5 µN/m (guaranteed)
z deflection noise density	0.5 pm/√Hz (dependent on laser system)
z bit resolution full range mode	7.6 pm
z bit resolution small range mode	0.12 pm
Scan Controller and Software	
ASC500 SPM controller	for detailed specifications please see attoCONTROL section

